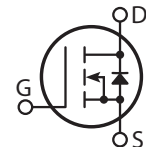
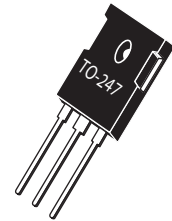


Super Junction MOSFET



- Ultra Low $R_{DS(ON)}$
- Low Miller Capacitance
- Ultra Low Gate Charge, Q_g
- Avalanche Energy Rated
- Extreme dv/dt Rated
- Dual die (parallel)
- Popular T-MAX Package

Unless stated otherwise, Microsemi discrete MOSFETs contain a single MOSFET die. This device is made with two parallel MOSFET die. It is intended for switch-mode operation. It is not suitable for linear mode operation.

MAXIMUM RATINGS

All Ratings per die: $T_C = 25^\circ\text{C}$ unless otherwise specified.

Symbol	Parameter	APT36N90BC3G	UNIT
V_{DSS}	Drain-Source Voltage	900	Volts
I_D	Continuous Drain Current @ $T_C = 25^\circ\text{C}$	36	Amps
	Continuous Drain Current @ $T_C = 100^\circ\text{C}$	23	
I_{DM}	Pulsed Drain Current ¹	96	
V_{GS}	Gate-Source Voltage Continuous	± 20	Volts
P_D	Total Power Dissipation @ $T_C = 25^\circ\text{C}$	390	Watts
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to 150	$^\circ\text{C}$
T_L	Lead Temperature: 0.063" from Case for 10 Sec.	260	
dv/dt	Drain-Source Voltage slope ($V_{DS} = 400\text{V}$, $I_D = 36\text{A}$, $T_J = 125^\circ\text{C}$)	50	V/ns
I_{AR}	Avalanche Current ²	8.8	Amps
E_{AR}	Repetitive Avalanche Energy ² ($I_d = 8.8\text{A}$, $V_{dd} = 50\text{V}$)	2.9	mJ
E_{AS}	Single Pulse Avalanche Energy ($I_d = 8.8\text{A}$, $V_{dd} = 50\text{V}$)	1940	

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$BV_{(DSS)}$	Drain-Source Breakdown Voltage ($V_{GS} = 0\text{V}$, $I_D = 250\mu\text{A}$)	900			Volts
$R_{DS(on)}$	Drain-Source On-State Resistance ³ ($V_{GS} = 10\text{V}$, $I_D = 18\text{A}$)		0.10	0.12	Ohms
I_{DSS}	Zero Gate Voltage Drain Current ($V_{DS} = 900\text{V}$, $V_{GS} = 0\text{V}$)	-	-	100	μA
	Zero Gate Voltage Drain Current ($V_{DS} = 900\text{V}$, $V_{GS} = 0\text{V}$, $T_C = 150^\circ\text{C}$)	-	50	-	
I_{GSS}	Gate-Source Leakage Current ($V_{GS} = \pm 20\text{V}$, $V_{DS} = 0\text{V}$)	-	-	100	nA
$V_{GS(th)}$	Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = 2.9\text{mA}$)	2.5	3	3.5	Volts

 CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

"COOLMOS™" comprise a new family of transistors developed by Infineon Technologies AG. "COOLMOS" is a trademark of Infineon Technologies AG.

Microsemi Website - <http://www.microsemi.com>

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C _{iss}	Input Capacitance	V _{GS} = 0V V _{DS} = 25V f = 1 MHz		7463		pF
C _{oss}	Output Capacitance			6827		
C _{rss}	Reverse Transfer Capacitance			167		
Q _g	Total Gate Charge ⁴	V _{GS} = 10V V _{DD} = 450V I _D = 36A @ 25°C		252		nC
Q _{gs}	Gate-Source Charge			38		
Q _{gd}	Gate-Drain ("Miller") Charge			112		
t _{d(on)}	Turn-on Delay Time	INDUCTIVE SWITCHING V _{GS} = 15V V _{DD} = 600V I _D = 36A @ 25°C R _G = 4.3Ω		70		ns
t _r	Rise Time			20		
t _{d(off)}	Turn-off Delay Time			400		
t _f	Fall Time			25		
E _{on}	Turn-on Switching Energy ⁵	INDUCTIVE SWITCHING @ 25°C V _{DD} = 600V, V _{GS} = 15V I _D = 36A, R _G = 4.3Ω		1500		μJ
E _{off}	Turn-off Switching Energy			750		
E _{on}	Turn-on Switching Energy ⁵	INDUCTIVE SWITCHING @ 125°C V _{DD} = 600V, V _{GS} = 15V I _D = 36A, R _G = 4.3Ω		2130		
E _{off}	Turn-off Switching Energy			867		

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
I _S	Continuous Source Current (Body Diode)		36		Amps
I _{SM}	Pulsed Source Current ¹ (Body Diode)		96		Amps
V _{SD}	Diode Forward Voltage ³ (V _{GS} = 0V, I _S = 18A)		0.8	1.2	Volts
dv/dt	Peak Diode Recovery ^{dv/dt} ⁶			10	V/ns
t _{rr}	Reverse Recovery Time (I _S = -36A, di/dt = 100A/μs)	T _J = 25°C		930	ns
		T _J = 125°C		1230	
Q _{rr}	Reverse Recovery Charge (I _S = -36A, di/dt = 100A/μs)	T _J = 25°C		35	μC
		T _J = 125°C		44	
I _{RRM}	Peak Recovery Current (I _S = -36A, di/dt = 100A/μs)	T _J = 25°C		70	Amps
		T _J = 125°C		68	

THERMAL CHARACTERISTICS

Symbol	Characteristic	MIN	TYP	MAX	UNIT
R _{θJC}	Junction to Case			0.3	°C/W
R _{θJA}	Junction to Ambient			31	

- 1 Repetitive Rating: Pulse width limited by maximum junction temperature
- 2 Repetitive avalanche causes additional power losses that can be calculated as P_{AV} = E_{AR}*f. Pulse width tp limited by Tj max.
- 3 Pulse Test: Pulse width < 380 μs, Duty Cycle < 2%
- 4 See MIL-STD-750 Method 3471
- 5 Eon includes diode reverse recovery.
- 6 Maximum 125°C diode commutation speed = di/dt 600A/μs

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

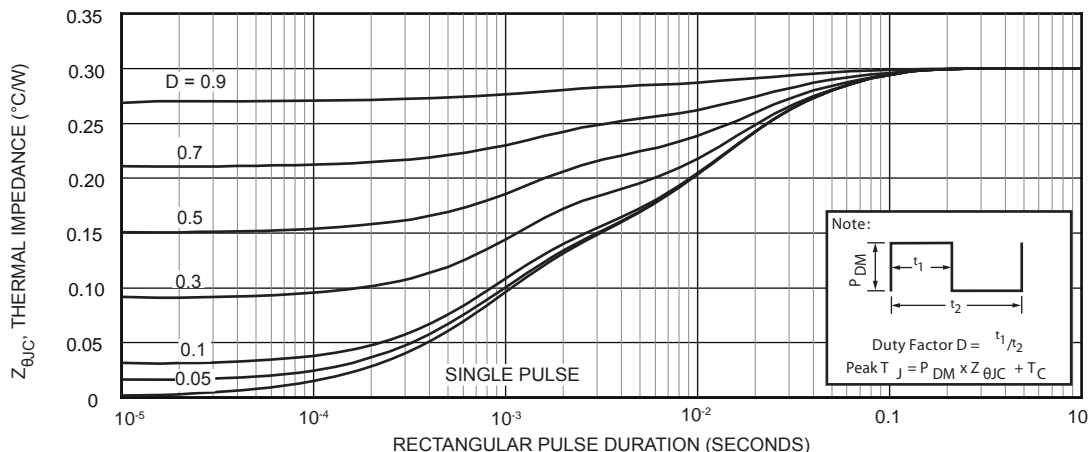


Figure 1, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration

Typical Performance Curves

APT36N90BC3G

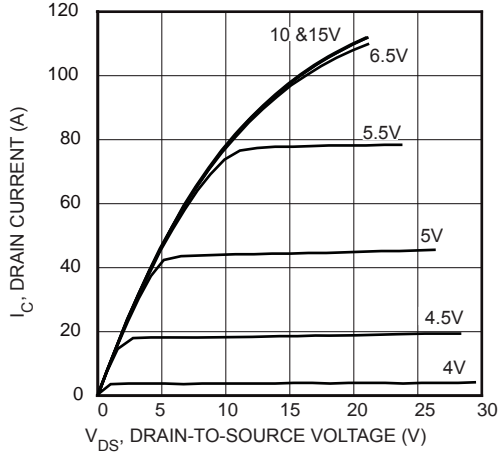


FIGURE 2, Low Voltage Output Characteristics

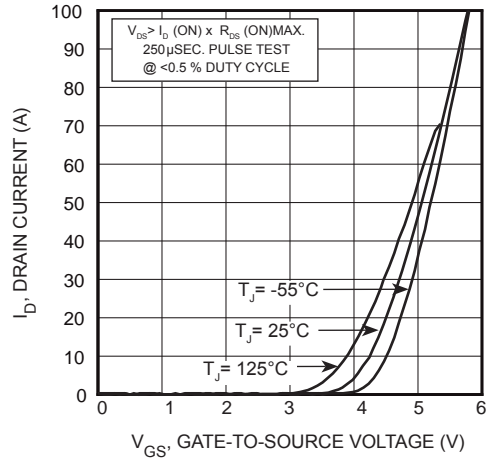


FIGURE 3, Transfer Characteristics

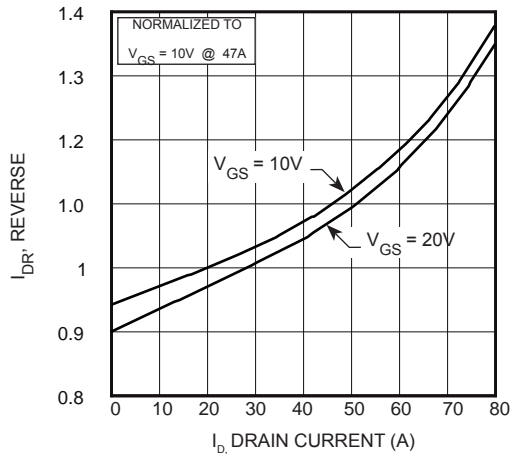


FIGURE 4, $R_{DS(ON)}$ vs Drain Current

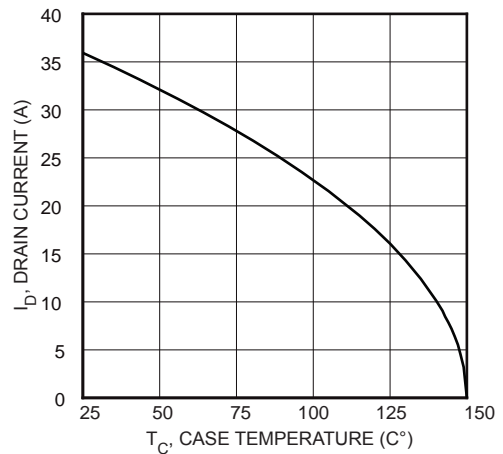


FIGURE 5, Maximum Drain Current vs Case Temperature

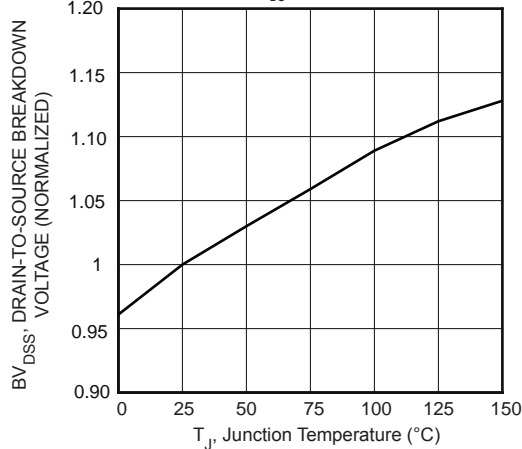


FIGURE 6, Breakdown Voltage vs Temperature

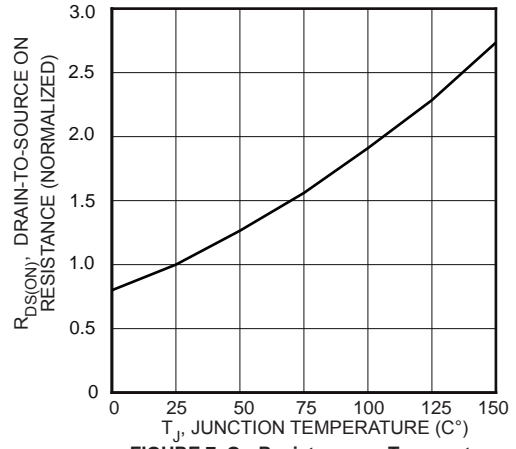


FIGURE 7, On-Resistance vs Temperature

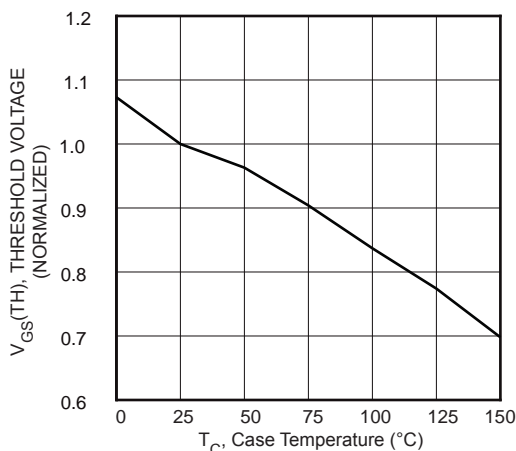


FIGURE 8, Threshold Voltage vs Temperature

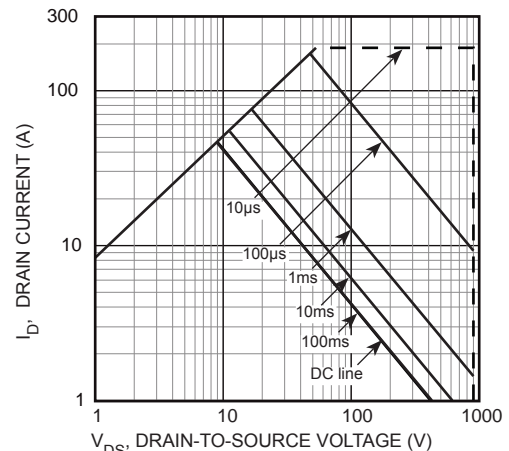


FIGURE 9, Maximum Safe Operating Area

Typical Performance Curves

APT36N90BC3G

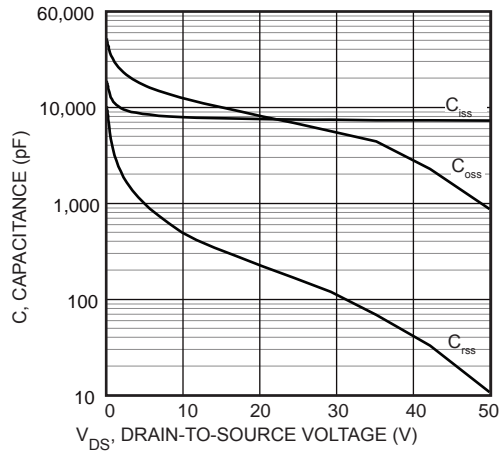


FIGURE 10, Capacitance vs Drain-To-Source Voltage

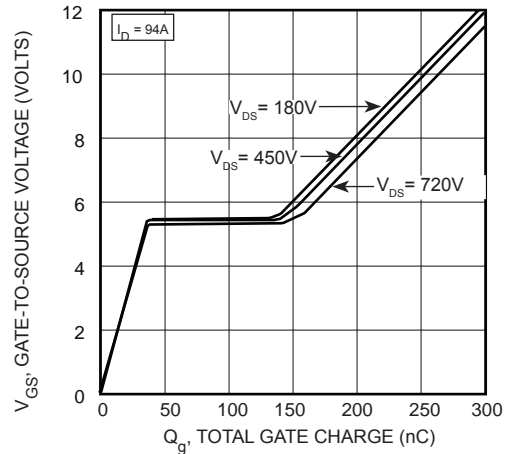


FIGURE 11, Gate Charges vs Gate-To-Source Voltage

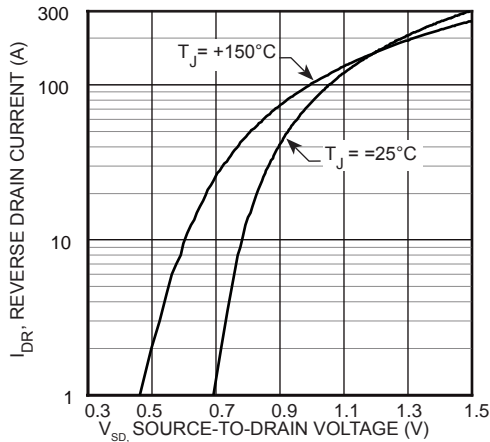


FIGURE 12, Source-Drain Diode Forward Voltage

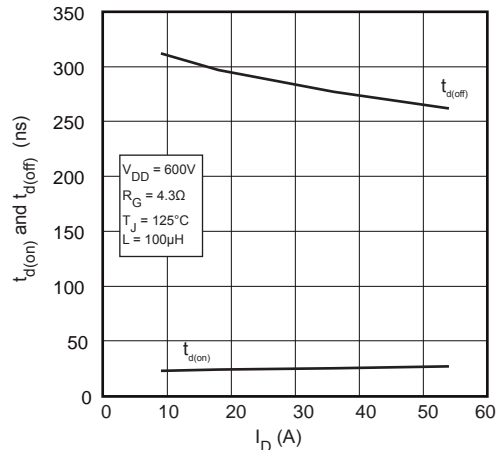


FIGURE 13, Delay Times vs Current

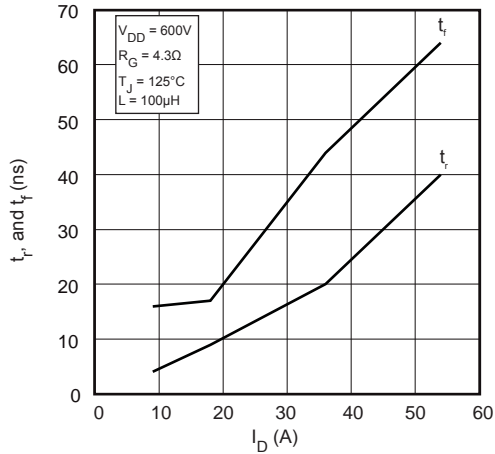


FIGURE 14, Rise and Fall Times vs Current

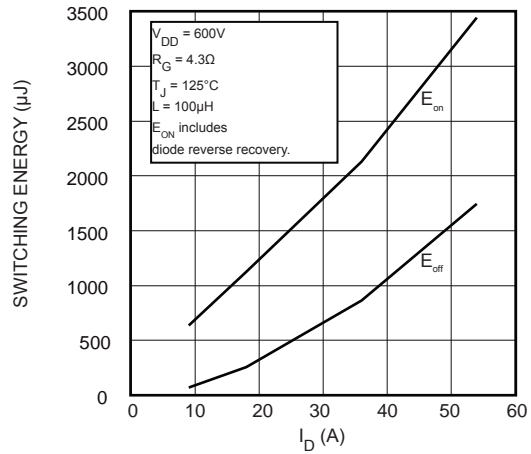


FIGURE 15, Switching Energy vs Current

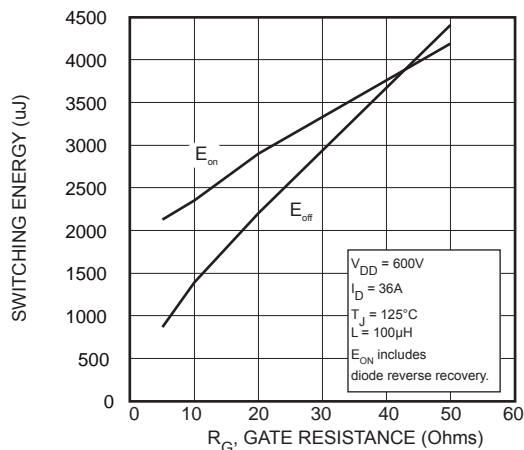


FIGURE 16, Switching Energy vs Gate Resistance

Typical Performance Curves

APT36N90BC3G

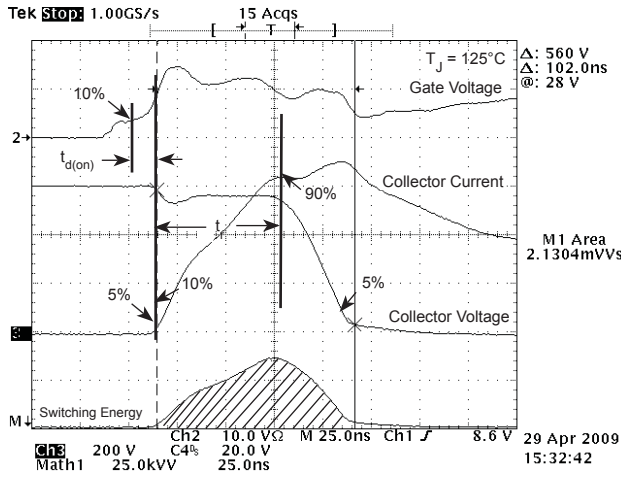


Figure 17, Turn-on Switching Waveforms and Definitions

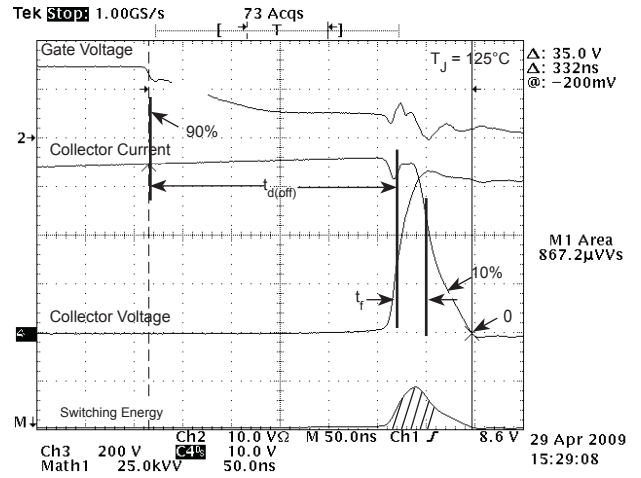


Figure 18, Turn-off Switching Waveforms and Definitions

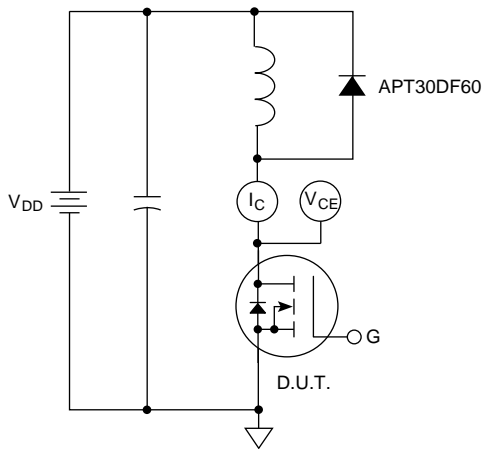
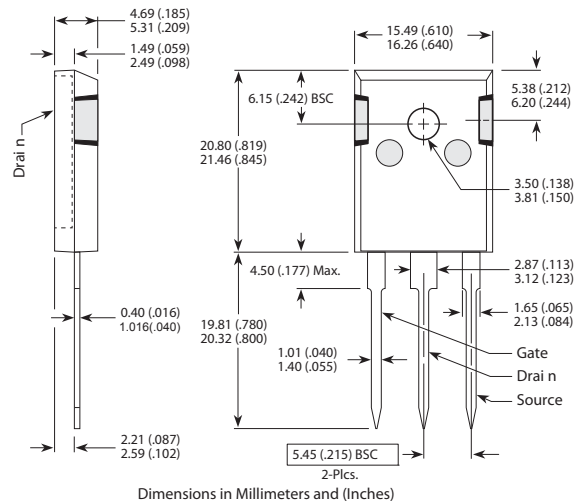


Figure 19, Inductive Switching Test Circuit

TO-247[®] Package Outline



Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

Мы предлагаем:

- Конкурентоспособные цены и скидки постоянным клиентам.
- Специальные условия для постоянных клиентов.
- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
- Доставку товара в любую точку России и стран СНГ.
- Комплексную поставку.
- Работу по проектам и поставку образцов.
- Формирование склада под заказчика.
- Сертификаты соответствия на поставляемую продукцию (по желанию клиента).
- Тестирование поставляемой продукции.
- Поставку компонентов, требующих военную и космическую приемку.
- Входной контроль качества.
- Наличие сертификата ISO.

В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- Регистрацию проекта у производителя компонентов.
- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



Тел: +7 (812) 336 43 04 (многоканальный)

Email: org@lifeelectronics.ru